# Beam dynamic simulations for the superconducting synchrotron SIS300 at FAIR

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# $\frac{210^{5} \cdot 10^{5} \cdot 10^{5}}{10^{5} \cdot 210^{5} \cdot 10^{5}} = \frac{2}{100^{5}} + \frac{$

Only particles with y=0 are actually reaching the separatrix, others have DA so small that are lost (unstable) before reaching separatix !!!

4 – adding field errors  $\rightarrow$  b3  $\rightarrow$  chromatic sextupoles have to be matched again to Hardt's condition



#### References

- [1] M. Borland, "Elegant: A Flexible SDDS-Compliant Code for Accelerator Simulation". Advanced Photon Source LS-287, September 2000.
- [2] Frank Schmidt et al, "MADX: Methodical Accelerator Design". CERN, June 2002.
  [3] M. Sorbi et al. Field quality and losses for the 4.5T Superconducting Pulsed Dipole of SIS300. Proceedings Magnet Technology MT-20.
- [4] A. Jain et al. Measurements of Field Quality in GS1001 at High Ramp Rates. Internal Note.

# Current effects in Superconducting Magnets

Magnetic field quality in SC magnets is determined by cable positioning and current effects (static and time-dependent)



- Persistent currents, its decay at constant current and reinduction (snapback)
- Field periodic pattern
  Coupling currents (between strands and between filaments) during ramps

Superconducting cable made of hard superconductor → hysteresis-like behavior (ramp rate dependent amplitude) → memory effects = dependence on previous cycles (powering history).

## Field Quality vs. Beam Dynamics

Magnetic field expanded in Taylor series

$$-iB_x = B_N^{(r)} \sum_{n=1}^{\infty} (b_n + ia_n) \left(\frac{z}{R_r}\right)^{n-1}$$
  $n=1$  dipolar comp  
 $n=2$  quadrupolar

components allowed depending on magnet symmetries

#### 1st step: static field errors

*B*., +

Field errors corresponding to the cycle flat top (4.5T) simulated with ROXIE  $^{[3]}$ 



Acceptance vs. dynamic aperture for different momentum spreads when adding field errors to the dipoles

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### 2<sup>nd</sup> step: time dependent field errors

Estimated variation of dynamic DA along a standard ramped cycle



At other facilities with SC magnets and lighter operation requirements (Tevatron, Hera, Rhic) the presence of:

- Non-allowed components (along whole cycle)
- Time dependent components (injection, flat top)
- Ramp rate dependent components (ramps)

limit machine operation!

- Different control methods used:
- static field description models
- off-line and on-line reference magnet systems